

<b>Notice of References Cited</b>	Application/Control No. 10/750,737	Applicant(s)/Patent Under Reexamination LANE, RICHARD	
	Examiner Ida M. Soward	Art Unit 2822	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,730,950	05-2004	Seshadri et al.	257/295
	B	US-2001/0045589	11-2001	Takeda et al.	257/297
	C	US-6,864,527	03-2005	DeBoer et al.	257/303
	D	US-2002/0024073	02-2002	Shimada et al.	257/295
	E	US-2002/0089059	07-2002	Imai, Shinichi	257/758
	F	US-4,903,110	02-1990	Aono, Yohichi	361/313
	G	US-2004/0129963	07-2004	Amo et al.	257/296
	H	US-2001/0022369	09-2001	Fukuda et al.	257/207
	I	US-2002/0135005	09-2002	Ma et al.	257/296
	J	US-2004/0150019	08-2004	Nakashima et al.	257/296
	K	US-6,207,987	03-2001	Tottori, Isao	257/306
	L	US-6,011,284	01-2000	Katori et al.	257/295
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.